Notice of References Cited Application/Control No. 10/647,633 Examiner Leslie J. Evanisko Applicant(s)/Patent Under Reexamination OTAKE ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,129,014	10-2000	Tani, Okie	101/126
	В	US-6,412,408	07-2002	Tanaka, Toshio	101/126
	С	US-	_		
	D	US-			
	Е	US-			
	F	US-			
	G	US-			_
	Н	US-			
	1	US-			
	J	US-			
	κ	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 3-75148	03-1991	Japan	Tamura, Keiichi	101/129
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	J	
	>	
	>	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.